

Application/Control No.	Applicant(s)/Patent under Reexamination
10/536,460	MIURA ET AL.
Examiner	Art Unit
Shawn X. Gu	2189

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
PALM Inventor Name Search	5/16/2007	SG		
EAST: US-PGPUB, USPAT, USOCR, FPRS, EPO, JPO, DERWENT, IBM_TDB (see text search history)	5/17/2007	SG		
EAST: US-PGPUB, USPAT, USOCR, FPRS, EPO, JPO, DERWENT, IBM_TDB (see updated text search history)	12/6/2007	SG		